

<b>Notice of References Cited</b>	Application/Control No. 10/626,775	Applicant(s)/Patent Under Reexamination KANG, HEE BOK	
	Examiner VanThu Nguyen	Art Unit 2824	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,226,200	05-2001	Eguchi et al.	365/185.19
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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